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Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









October 2001

IGBT

SGF40N60UF

Ultra-Fast IGBT

General Description

Fairchild's Insulated Gate Bipolar Transistor(IGBT) UF series provides low conduction and switching losses. UF series is designed for the applications such as motor control and general inverters where High Speed Switching is required.

Features

- · High Speed Switching
- Low Saturation Voltage : $V_{CE(sat)} = 2.1 \text{ V } @ I_C = 20 \text{A}$
- High Input Impedance

Application

AC & DC Motor controls, General Purpose Inverters, Robotics, Servo Controls





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Description		SGF40N60UF	Units
V _{CES}	Collector-Emitter Voltage		600	V
V _{GES}	Gate-Emitter Voltage		± 20	V
_	Collector Current	@ T _C = 25°C	40	Α
I _C	Collector Current	@ T _C = 100°C	20	А
I _{CM (1)}	Pulsed Collector Current		160	Α
P_{D}	Maximum Power Dissipation	@ T _C = 25°C	100	W
	Maximum Power Dissipation	@ T _C = 100°C	40	W
TJ	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Sec		300	°C

Notes :

(1) Repetitive rating : Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W

Electrical Characteristics of IGBT T _C = 25°C unless otherwise noted						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Cha	racteristics					
BV _{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250uA$	600			V
$\Delta B_{VCES}/$ ΔT_J	Temperature Coeff. of Breakdown Voltage	$V_{GE} = 0V$, $I_C = 1mA$		0.6		V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			250	uA
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 100	nA
On Chai	racteristics					
V _{GE(th)}	G-E Threshold Voltage	$I_C = 20mA$, $V_{CE} = V_{GE}$	3.5	4.5	6.5	V
	Collector to Emitter	I _C = 20A, V _{GE} = 15V		2.1	2.6	V
V _{CE(sat)}	Saturation Voltage	$I_C = 40A$, $V_{GE} = 15V$		2.6		V
-	c Characteristics		I		T	
C _{ies}	Input Capacitance	$V_{CE} = 30V$, $V_{GE} = 0V$,		1430		pF
C	Output Capacitance			170		pF
Cros		f = 1MHz				
C _{oes} C _{res}	Reverse Transfer Capacitance	f = 1MHz		50		pF
C _{res}	Reverse Transfer Capacitance ng Characteristics	f = 1MHz				
C _{res}	Reverse Transfer Capacitance	f = 1MHz				
C_{res} Switchin $t_{d(on)}$	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Rise Time			50		pF
Switchir	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time	V _{CC} = 300 V, I _C = 20A,		50		pF
$\frac{\mathbf{C}_{\text{res}}}{\mathbf{Switchir}}$ $\frac{\mathbf{t}_{\text{d(on)}}}{\mathbf{t}_{\text{r}}}$ $\frac{\mathbf{t}_{\text{d(off)}}}{\mathbf{t}_{\text{f}}}$	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$		50 15 30		pF ns ns
$\frac{C_{res}}{\textbf{Switchin}}$ $\frac{t_{d(on)}}{t_r}$ $\frac{t_{d(off)}}{t_f}$ t_{f} E_{on}	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	V _{CC} = 300 V, I _C = 20A,	 	50 15 30 65	 130	ns ns
$\frac{C_{res}}{\textbf{Switchin}}$ $\frac{t_{d(on)}}{t_r}$ $\frac{t_{d(off)}}{t_f}$ t_{f} E_{on}	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$	 	15 30 65 50	 130 150	ns ns ns
$\begin{aligned} & C_{res} \\ & \textbf{Switchir} \\ & t_{d(on)} \\ & t_{r} \\ & t_{d(off)} \\ & t_{f} \\ & E_{on} \\ & E_{off} \end{aligned}$	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$	 	15 30 65 50 160	 130 150	ns ns ns ns
$\begin{aligned} & \frac{C_{res}}{Switchin} \\ & \frac{t_{d(on)}}{t_r} \\ & \frac{t_{d(off)}}{t_f} \\ & \frac{E_{on}}{E_{ts}} \end{aligned}$	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$	 	50 15 30 65 50 160 200	 130 150 	ns ns ns uJ
$\begin{aligned} & C_{res} \\ & \textbf{Switchin} \\ & \frac{t_{d(on)}}{t_r} \\ & t_r \\ & \frac{t_{d(off)}}{t_f} \\ & E_{on} \\ & E_{off} \\ & E_{ts} \\ & \frac{t_{d(on)}}{t_{d(on)}} \end{aligned}$	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$	 	50 15 30 65 50 160 200 360	 130 150 600	ns ns ns ns uJ uJ
$\begin{aligned} & \frac{C_{res}}{Switchin} \\ & \frac{t_{d(on)}}{t_r} \\ & \frac{t_{d(off)}}{t_f} \\ & \frac{E_{on}}{E_{ts}} \\ & \frac{t_{d(on)}}{t_r} \end{aligned}$	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time	V_{CC} = 300 V, I_{C} = 20A, R_{G} = 10 Ω , V_{GE} = 15V, Inductive Load, T_{C} = 25°C	 	50 15 30 65 50 160 200 360 30	 130 150 600	ns ns ns ns uJ uJ uJ
Cres Switchin td(on) tr td(off) tf Eon Ets td(on) tr td(off)	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$	 	50 15 30 65 50 160 200 360 30 37	 130 150 600	ns ns ns ns uJ uJ uJ ns
C_{res} Switchin $t_{d(on)}$ t_r $t_{d(off)}$ t_f E_{on} E_{ts} $t_{d(on)}$ t_r $t_{d(on)}$ t_r	Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$ Inductive Load, $T_{C} = 25^{\circ}\text{C}$ $V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$		50 15 30 65 50 160 200 360 30 37 110	 130 150 600 200	ns ns ns ns uJ uJ uJ ns ns
Cres Switchin td(on) tr td(off) tf Eon Ets td(on) tr td(off) tf Ets td(on) tr tr td(off)	Reverse Transfer Capacitance Ing Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$ Inductive Load, $T_{C} = 25^{\circ}\text{C}$ $V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$		50 15 30 65 50 160 200 360 30 37 110 144	 130 150 600 200 250	ns ns ns ns uJ uJ ns ns
Cres Switchin td(on) tr td(off) tf Eon Ets td(on) tr td(off) Ets td(on) tr td(off) tf Eon Ets	Reverse Transfer Capacitance Ig Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-Off Delay Time Fall Time Turn-On Switching Loss	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$ Inductive Load, $T_{C} = 25^{\circ}\text{C}$ $V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$ $R_{G} = 10\Omega, V_{GE} = 15\text{V},$		50 15 30 65 50 160 200 360 30 37 110 144 310	 130 150 600 200 250	ns ns ns ns uJ uJ ns ns ns
Cres Switchin td(on) tr td(off) tf Eon Ets td(off) tr td(off) tr Ets td(on) tr tr td(off) tr td(off) tr td(off)	Reverse Transfer Capacitance Ig Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss	$V_{CC} = 300 \text{ V, } I_{C} = 20\text{A,}$ $R_{G} = 10\Omega, V_{GE} = 15\text{V,}$ $Inductive \ Load, \ T_{C} = 25^{\circ}\text{C}$ $V_{CC} = 300 \text{ V, } I_{C} = 20\text{A,}$ $R_{G} = 10\Omega, V_{GE} = 15\text{V,}$ $Inductive \ Load, \ T_{C} = 125^{\circ}\text{C}$		50 15 30 65 50 160 200 360 30 37 110 144 310 430	 130 150 600 200 250	ns ns ns ns uJ uJ ns ns ns
$\begin{array}{l} \textbf{Switchin} \\ \textbf{Switchin} \\ \hline t_{d(on)} \\ t_r \\ \hline t_{d(off)} \\ t_t \\ \hline E_{on} \\ \hline E_{ts} \\ \hline t_{d(on)} \\ t_r \\ \hline t_{d(off)} \\ t_r \\ \hline E_{on} \\ \hline E_{ts} \\ \hline t_{d(off)} \\ t_{r} \\ \hline E_{on} \\ E_{on} \\ \hline E_{$	Reverse Transfer Capacitance Ig Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-Off Switching Loss Turn-Off Switching Loss Turn-Off Switching Loss Turn-Off Switching Loss Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Total Gate Charge	$V_{CC} = 300 \text{ V, } I_{C} = 20\text{A,}$ $R_{G} = 10\Omega, V_{GE} = 15\text{V,}$ Inductive Load, $T_{C} = 25^{\circ}\text{C}$ $V_{CC} = 300 \text{ V, } I_{C} = 20\text{A,}$ $R_{G} = 10\Omega, V_{GE} = 15\text{V,}$ Inductive Load, $T_{C} = 125^{\circ}\text{C}$ $V_{CE} = 300 \text{ V, } I_{C} = 20\text{A,}$		50 15 30 65 50 160 200 360 30 37 110 144 310 430 740	 130 150 600 200 250 1200	ns ns ns uJ uJ ns ns ns us
C _{res} Switchin	Reverse Transfer Capacitance Ig Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-Off Switching Loss Turn-Off Switching Loss Turn-Off Switching Loss Turn-On Switching Loss Turn-Off Switching Loss Turn-Off Switching Loss	$V_{CC} = 300 \text{ V, } I_{C} = 20\text{A,}$ $R_{G} = 10\Omega, V_{GE} = 15\text{V,}$ $Inductive \ Load, \ T_{C} = 25^{\circ}\text{C}$ $V_{CC} = 300 \text{ V, } I_{C} = 20\text{A,}$ $R_{G} = 10\Omega, V_{GE} = 15\text{V,}$ $Inductive \ Load, \ T_{C} = 125^{\circ}\text{C}$		50 15 30 65 50 160 200 360 30 37 110 144 310 430 740 97	 130 150 600 200 250 1200 150	ns ns ns ns uJ uJ ns ns ns uJ uJ

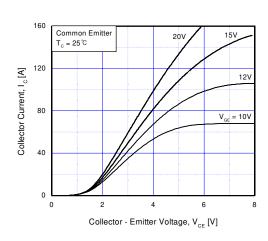
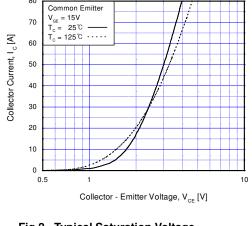


Fig 1. Typical Output Characteristics



80

Fig 2. Typical Saturation Voltage Characteristics

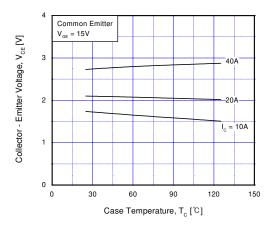


Fig 3. Saturation Voltage vs. Case
Temperature at Variant Current Level

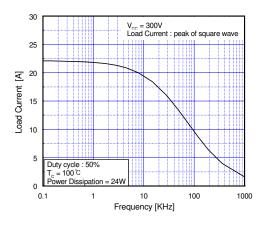


Fig 4. Load Current vs. Frequency

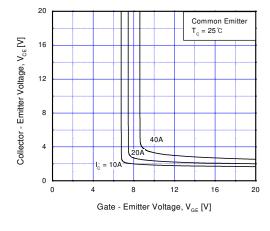


Fig 5. Saturation Voltage vs. V_{GE}

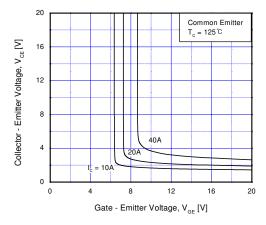
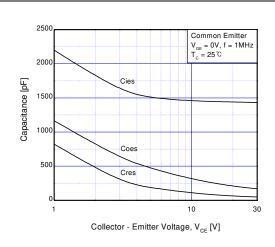


Fig 6. Saturation Voltage vs. $V_{\rm GE}$

SGF40N60UF Rev. A

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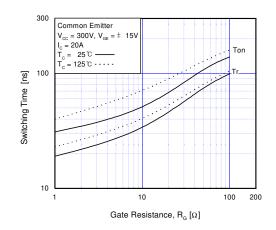
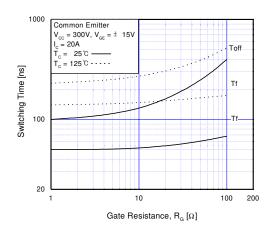


Fig 7. Capacitance Characteristics

Fig 8. Turn-On Characteristics vs.
Gate Resistance



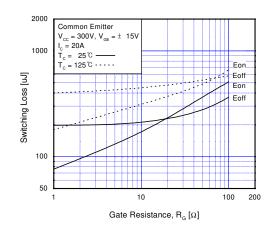
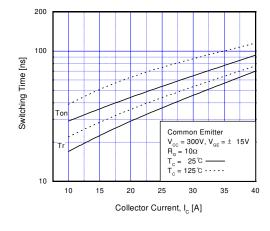


Fig 9. Turn-Off Characteristics vs.
Gate Resistance

Fig 10. Switching Loss vs. Gate Resistance



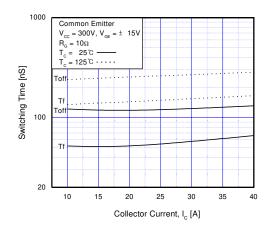
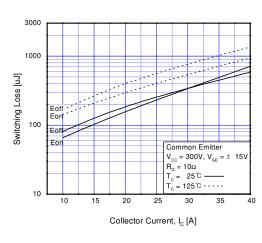


Fig 11. Turn-On Characteristics vs. Collector Current

Fig 12. Turn-Off Characteristics vs. Collector Current



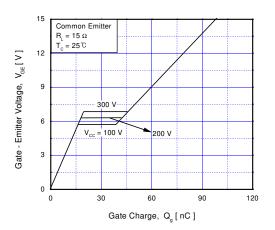
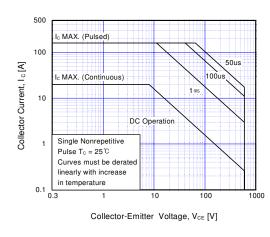


Fig 13. Switching Loss vs. Collector Current

Fig 14. Gate Charge Characteristics



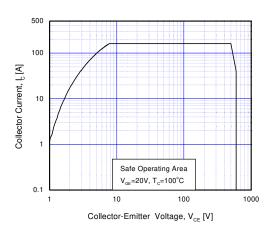


Fig 15. SOA Characteristics

Fig 16. Turn-Off SOA Characteristics

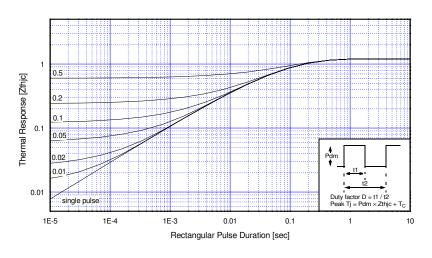
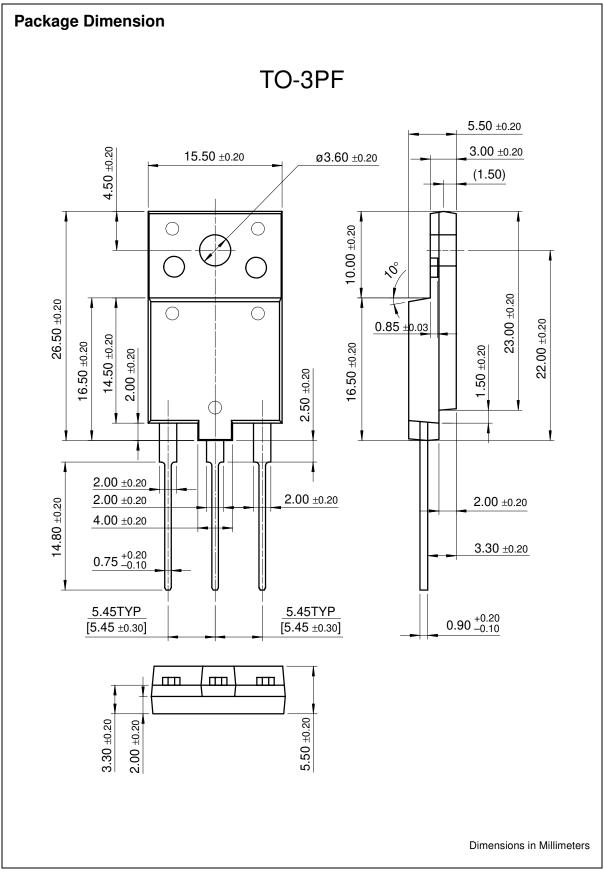


Fig 17. Transient Thermal Impedance of IGBT

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Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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